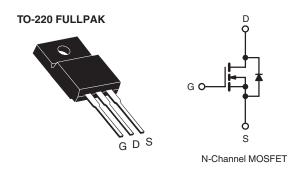


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	60			
$R_{DS(on)}(\Omega)$	V _{GS} = 5.0 V	0.20		
Q _g (Max.) (nC)	8.4			
Q _{gs} (nC)	3.5			
Q _{gd} (nC)	6.0			
Configuration	Single			



FEATURES

- · Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz



- Sink to Lead Creepage Distance = 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRLIZ14GPbF
Leau (FD)-liee	SiHLIZ14G-E3
SnPb	IRLIZ14G
SIFD	SiHLIZ14G

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	60	V	
Gate-Source Voltage			V_{GS}	± 10	l v	
Continuous Drain Current	V -+ 5 0 V	T _C = 25 °C	- I _D	8.0	A	
	V _{GS} at 5.0 V	$T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$		5.7		
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				0.18	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	39.5	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	27	W	
Peak Diode Recovery dV/dtc			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d]	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25$ V, starting $T_J=25$ °C, L=0.79 mH, $R_G=25$ Ω , $I_{AS}=10$ A (see fig. 12). c. $I_{SD}\leq 10$ A, $dI/dt\leq 90$ A/ μ s, $V_{DD}\leq V_{DS}$, $T_J\leq 175$ °C.

- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLIZ14G, SiHLIZ14G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	5.5	C/VV	

PARAMETER	SYMBOL	TES	TEST CONDITIONS		TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		1-1	0.070	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA		1.0	-	2.0	٧
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 10 V		-	± 100	nA
Zava Cata Valtaga Drain Current	1	V _{DS} = 60 V, V _{GS} = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	В	V _{GS} = 5.0 V	$I_D = 4.8 A^b$	-	-	0.20	0
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	I _D = 4.0 A ^b	-	-	0.28	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 25 V, I _D = 4.8 A ^b		3.6	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	400	-	
Output Capacitance	C _{oss}	$V_{DS} = 25 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	170	-	- pF
Reverse Transfer Capacitance	C_{rss}			-	42	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Q_g			-	-	8.4	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$I_D = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.5	
Gate-Drain Charge	Q_{gd}		oco ng. o ana ro	-	-	6.0	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 30 \text{ V}, I_{D} = 10 \text{ A},$ $R_{G} = 12 \Omega R_{D} = 2.8 \Omega,$ see fig. 10^{b}		-	9.3	-	- ns
Rise Time	t _r			-	110	-	
Turn-Off Delay Time	t _{d(off)}			-	17	-	
Fall Time	t _f			-	26	-	
Internal Drain Inductance	L_{D}	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	-11
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	-					
Continuous Source-Drain Diode Current	I _S	showing the	MOSFET symbol showing the		-	8.0	- A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	32	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 8.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 {}^{\circ}\text{C}, \ I_F = 10 \text{A}, \ \text{dI/dt} = 100 \text{A/}\mu\text{s}^b$		-	65	130	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.33	0.65	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	-on is don	ninated by	L _S and I	_D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

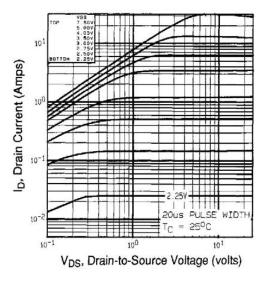


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

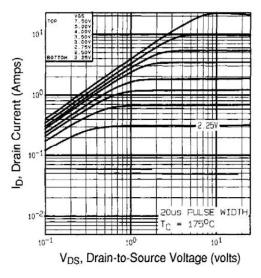


Fig. 2 - Typical Output Characteristics, T_C= 175 °C

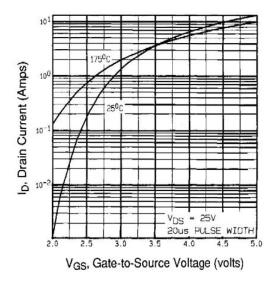


Fig. 3 - Typical Transfer Characteristics

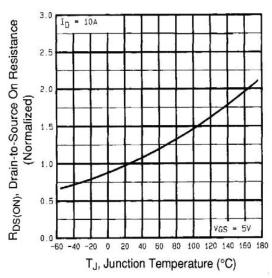


Fig. 4 - Normalized On-Resistance vs. Temperature

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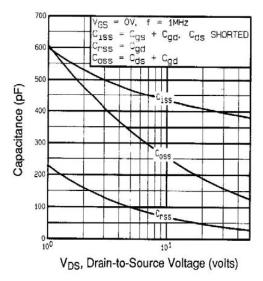


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

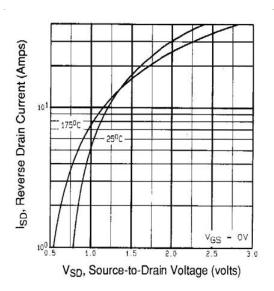


Fig. 7 - Typical Source-Drain Diode Forward Voltage

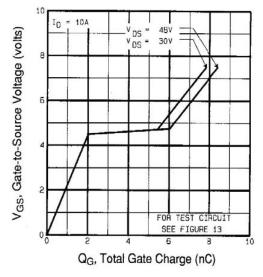


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

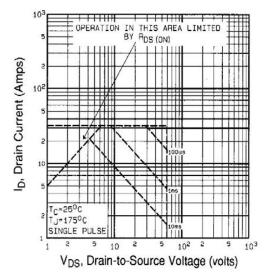


Fig. 8 - Maximum Safe Operating Area



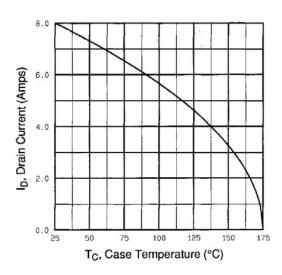


Fig. 9 - Maximum Drain Current vs. Case Temperature

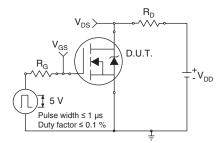


Fig. 10a - Switching Time Test Circuit

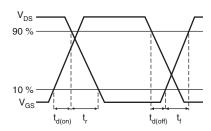
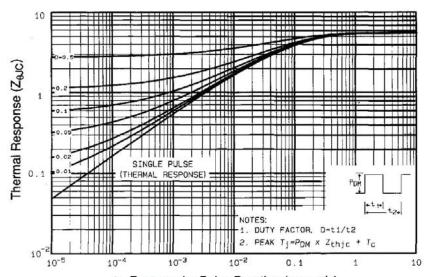


Fig. 10b - Switching Time Waveforms



t₁, Rectangular Pulse Duration (seconds)

Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

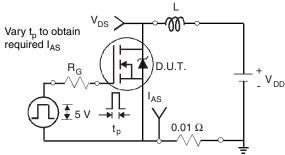


Fig. 12a - Unclamped Inductive Test Circuit

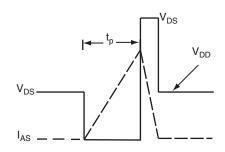
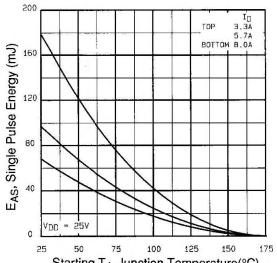


Fig. 12b - Unclamped Inductive Waveforms

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 $Starting \ T_J, \ Junction \ Temperature (^{\circ}C)$ Fig. 12c - Maximum Avalanche Energy vs. Drain Current

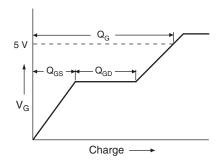


Fig. 13a - Basic Gate Charge Waveform

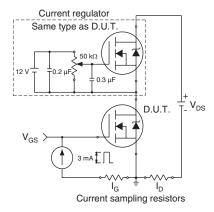
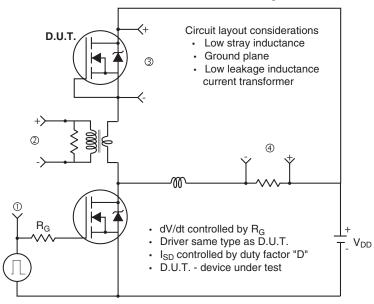
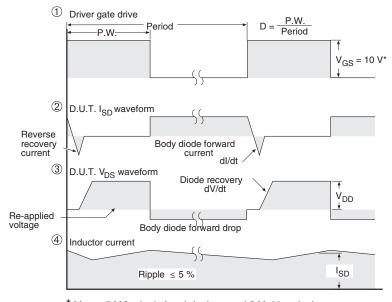


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





 * V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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